# **Carrier Quality Analyzer**

# PN9000 Test System



Modular design provides the flexibility to simply, automatically and quickly measure and plot:

- Phase noise
- AM noise
- Added noise
- Jitter
- Allan variance
- Integrated power and spurii

Of almost any device from 2 MHz to 140 GHz.

These include:

- . Crystal oscillators, OCXO, TCXO
- . Stable sources, synthesizers, PDROs
- . Radar systems and other pulse systems, TDMA
- . Unstable sources, VCOs, DROs
- . Multiport devices, amplifiers, mixers, Up/Down convertors

### **SPECIFICATIONS**

#### Input Frequency Measurement Range

2 MHz to 1.8 GHz Options up to 140 GHz

#### **Offset Measurement Range**

0.01 Hz to 1 MHz, Option to 40 MHz

PN9500 0.01 Hz to 500 MHz

#### Accuracy

+/-2 dB to 1 MHz offset, +/- 3 dB to 40 MHz offset

#### Residual System Noise (dBc/Hz)

Offset from Carrier	Standard	High Level	Microwave
1 Hz	-130	-140	-120
10 Hz	-140	-150	-130
100 Hz	-150	-160	-140
1 kHz	-160	-170	-150
10 kHz and above	-170	-178	-160



## For the very latest specifications visit WWW.aeroflex.com

A passion for performance.

#### MAIN OPTIONS

- PN9100 Internal low noise reference signal generator, 2 MHz to 4.5 GHz, options to 18 GHz, usable to 40 GHz
- PN9718 Internal 20 and 100 ns Delay Line, 250 MHz to 2 GHz. Used to measure unstable sources. Other frequencies can be measured using downconverters.
- PN9276 Internal microwave downconverter, 1.7 to 18 GHz, 26.5 to 40 GHz
- PN9511 Internal Ultra Low Noise 10 MHz VCOXCO. Other frequencies available. Enables testing of oven or other low noise crystal oscillators.
- PN9841 Internal Added Noise Phase Shifter and Splitter, 2 to 18 GHz. Used to measure phase noise on Amplifiers and/or Radar systems.
- PN9692 -HR ATE and high speed option

Many other options available as standard. Also custom modules to suit your application.

The PN9000 overcomes all of the problems associated with trying to measure phase noise with any Spectrum Analyzer:

- Can measure very close to Carrier (0.01 Hz away).
- · Can distinguish between PM and AM noise, and measure both separately.
- · Ensures you are not measuring the Spectrum Analyzer's LO phase noise (noise cancellation does not fully resolve this).
- · Has an extremely low residual noise floor (-178 dBc/Hz).
- Can use any low noise signal generator as the reference LO (as long as it has GPIB/RS232 control and an external FM input).
- Can measure unstable devices.
- · Can measure multiport devices.



The upper plot shows a real 930 MHz GSM VCO. It shows that the residual noise is low enough to measure "state of the art" new generation VCOs



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Jitter plots can be generated with user defined jitter masks. RMS and peak measurements down to 1 femto second.



Phase Noise plots can be saved as plots for further analysis, or as BMPs or JPEGS.

Post measurement analysis; spurii table with user determinable limits. Limit lines, 10 markers, Jitter measurements/plots to femto-second resolution. Smoothing, variance, Allan, true, modified, TV AR. Process, trace A + trace B etc. All of the above, and more, can be done away from the system, on your own PC, with the supplied software.



Our passion for performance is defined by three attributes represented by these three icons: solution-minded, performance-driven and customer-focused.

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### www.aeroflex.com

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Automatic setup and calibration simplifies operation, reduces test time and the likelihood of measurement errors.

Manual setup and calibration available to those who wish to use it.